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1 INTRODUCTION

1.1 PURPOSE AND SCOPE

This document is a product specification, providing description, specifications, and design related information on the IAM-20380 automotive gyroscope device. The device is housed in a small 3x3x0.75 mm 16-pin LGA package.

1.2 PRODUCT OVERVIEW

The IAM-20380 is a 3-axis gyroscope for Automotive applications that features a 3-axis gyroscope in a small 3x3x0.75 mm (16-pin LGA) package. It also features a 512-byte FIFO that can lower the traffic on the serial bus interface and reduce power consumption by allowing the system processor to burst read sensor data and then go into a low-power mode. IAM-20380, with its 3-axis integration, enables manufacturers to eliminate the costly and complex selection, qualification, and system level integration of discrete devices, guaranteeing optimal motion performance.

The gyroscope has a programmable full-scale range of ±250 dps, ±500 dps, ±1000 dps, and ±2000 ds. Factory-calibrated initial sensitivity reduces production-line calibration requirements.

Other industry-leading features include on-chip 16-bit ADCs, programmable digital filters, an embedded temperature sensor, and programmable interrupts. The device features I^2C and SPI serial interfaces, a VDD operating range of 1.71V to 3.6V, and a separate digital IO supply, VDDIO from 1.71V to 3.6V.

Communication with all registers of the device is performed using either I²C at 400 kHz or SPI at 8 MHz.

By leveraging its patented and volume-proven CMOS-MEMS fabrication platform, which integrates MEMS wafers with companion CMOS electronics through wafer-level bonding, InvenSense has driven the package size down to a footprint and thickness of 3x3x0.75 mm (16-pin LGA), to provide a very small yet high-performance, low-cost package. The device provides high robustness by supporting 10,000g shock reliability.

1.3 APPLICATIONS

- Navigation Systems Aids for Dead Reckoning
- Lift Gate Motion Detections
- Accurate Location for Vehicle to Vehicle and Infrastructure
- 360^o View Camera Stabilization
- Car Alarm
- Telematics
- Insurance Vehicle Tracking

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2 FEATURES

2.1 GYROSCOPE FEATURES

The triple-axis MEMS gyroscope in the IAM-20380 includes a wide range of features:

- Digital-output X-, Y-, and Z-axis angular rate sensors (gyroscopes) with a user-programmable full-scale range of ±250 dps, ±500 dps, ±1000 dps, and ±2000 dps and integrated 16-bit ADCs
- Digitally-programmable low-pass filter
- Low-power gyroscope operation
- · Factory calibrated sensitivity scale factor
- Self-test

2.2 ADDITIONAL FEATURES

The IAM-20380 includes the following additional features:

- Smallest and thinnest LGA package for portable devices: 3x3x0.75 mm (16-pin LGA)
- 512-byte FIFO buffer enables the applications processor to read the data in bursts
- Digital-output temperature sensor
- User-programmable digital filters for gyroscope and temperature sensor
- 10,000*g* shock tolerant
- 400 kHz Fast Mode I²C for communicating with all registers
- 8 MHz SPI serial interface for communicating with all registers
- MEMS structure hermetically sealed and bonded at wafer level
- · RoHS and Green compliant



3 ELECTRICAL CHARACTERISTICS

3.1 GYROSCOPE SPECIFICATIONS

Typical Operating Circuit of section 4.2, VDD = 1.8V, VDDIO = 1.8V, TA = 25°C, unless otherwise noted.

All Zero-rate output, sensitivity, and noise specifications include board soldering effects.

PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
	GYROSCOPE SENSITIVITY					
Full-Scale Range	FS_SEL=0		±250		dps	3
	FS_SEL=1		±500		dps	3
	FS_SEL=2		±1000		dps	3
	FS_SEL=3		±2000		dps	3
Gyroscope ADC Word Length			16		bits	3
Sensitivity Scale Factor	FS_SEL=0		131		LSB/(dps)	3
	FS_SEL=1		65.5		LSB/(dps)	3
	FS_SEL=2		32.8		LSB/(dps)	3
	FS_SEL=3		16.4		LSB/(dps)	3
Nonlinearity	Best fit straight line; 25°C		±0.1		%	1
Cross-Axis Sensitivity	25°C		±5		%	1
	ZERO-RATE OUTPUT (ZRO)					
Initial ZRO Tolerance	25°C		-0.8		dps	2
ZRO Variation Over Temperature	-40°C to +85°C		±1		dps	1
GY	ROSCOPE NOISE PERFORMANCE (F	S_SEL=0)				
	-40°C to +85°C		0.005		dps/√Hz	1,4
Rate Noise Spectral Density	-40°C to +85°C, including		0.010		dps/√Hz	1,4
	lifetime drift		0.010		ups/vnz	1,4
Gyroscope Mechanical Frequencies		25	27	29	KHz	2
Low Pass Filter Response	Programmable Range	5		250	Hz	3
Gyroscope Start Up Time	From Sleep mode		35		ms	1
Output Data Rate	Programmable, Normal (Filtered) mode	4		8000	Hz	1

Table 1. Gyroscope Specifications

Please contact InvenSense for a datasheet with maximum and minimum performance values over temperature and lifetime.

Notes:

- 1. Derived from validation or characterization of parts, not guaranteed in production.
- 2. Tested in production.
- 3. Guaranteed by design.
- 4. Calculated from Total RMS Noise.

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3.2 ELECTRICAL SPECIFICATIONS

3.2.1 D.C. Electrical Characteristics

Typical Operating Circuit of section 4.2, VDD = 1.8V, VDDIO = 1.8V, T_A = 25°C, unless otherwise noted.

PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS	NOTES		
SUPPLY VOLTAGES								
VDD		1.71	1.8	3.6	V	1		
VDDIO		1.71	1.8	3.6	V	1		
	SUPPLY CURRENTS & BOOT TIP	ME						
Normal Mode	3-axis Gyroscope		2.6		mA	1		
Gyroscope Low-Power Mode	100 Hz ODR, 1x averaging		1.6		mA	2		
Full-Chip Sleep Mode			6		μΑ	1		
TEMPERATURE RANGE								
Specified Temperature Range	Performance parameters are not applicable beyond Specified Temperature Range	-40		+85	°C	1		

Table 2. D.C. Electrical Characteristics

Notes:

- 1. Derived from validation or characterization of parts, not guaranteed in production.
- 2. Based on simulation.



3.2.2 A.C. Electrical Characteristics

Typical Operating Circuit of section 4.2, VDD = 1.8V, VDDIO = 1.8V, T_A = 25°C, unless otherwise noted.

PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
	SU	PPLIES				
Supply Ramp Time (T _{RAMP})	Monotonic ramp. Ramp	0.01		100	ms	1
	rate is 10% to 90% of the					
	final value					
		TURE SENSOR		1		
Operating Range	Ambient	-40		85	°C	1
Room Temperature Offset	25°C		0		°C	1
Sensitivity	Untrimmed		326.8		LSB/°C	1
		R-ON RESET		1		
Supply Ramp Time (T _{RAMP})	Valid power-on RESET	0.01		100	ms	1
Start-up time for register read/write	From power-up		11	100	ms	1
Start up time for register ready write	From sleep			5	ms	1
I ² C ADDRESS	SA0 = 0		1101000			
	SA0 = 1		1101001			
	DIGITAL INPUTS (FS		SDI, CS)	1		
V _{IH} , High Level Input Voltage		0.7*VDDIO			V	
V _{IL} , Low Level Input Voltage				0.3*VDDIO	V	1
C _I , Input Capacitance			< 10		pF	
		TPUT (SDO, INT)	T	1		
V _{OH} , High Level Output Voltage	$R_{LOAD}=1 M\Omega;$	0.9*VDDIO			V	
V _{OL1} , LOW-Level Output Voltage	$R_{LOAD}=1 M\Omega;$			0.1*VDDIO	V	
V _{OL.INT} , INT Low-Level Output Voltage	OPEN=1, 0.3 mA sink			0.1	V	1
	Current					_
Output Leakage Current	OPEN=1		100		nA	
t _{INT} , INT Pulse Width	LATCH_INT_EN=0		50		μs	
	I ² C I/O	(SCL, SDA)	T	1		
V _{IL} , LOW Level Input Voltage		-0.5V		0.3*VDDIO	V	
V _{IH} , HIGH-Level Input Voltage		0.7*VDDIO		VDDIO + 0.5	V	
				V		
V _{hys} , Hysteresis			0.1*VDDIO		V	
V _{OL} , LOW-Level Output Voltage	3 mA sink current	0		0.4	V	1
I _{OL} , LOW-Level Output Current	V _{OL} =0.4V		3		mA	=
	V _{OL} =0.6V		6		mA	
Output Leakage Current			100		nA	
$t_{\text{of}}\text{, Output Fall Time from }V_{\text{IHmax}}$ to V_{ILmax}	C _b bus capacitance in pf	20+0.1C _b		300	ns	



	INTERNAL CLOCK SOURCE								
	FCHOICE_B=1,2,3 SMPLRT_DIV=0		32		kHz	2			
Sample Rate	FCHOICE_B=0; DLPFCFG=0 or 7 SMPLRT_DIV=0		8		kHz	2			
	FCHOICE_B=0; DLPFCFG=1,2,3,4,5,6; SMPLRT_DIV=0		1		kHz	2			
Clack Fraguency Initial Tolorance	CLK_SEL=0, 6 or gyro inactive; 25°C	-5		+5	%	1			
Clock Frequency Initial Tolerance	CLK_SEL=1,2,3,4,5 and gyro active; 25°C	-1		+1	%	1			
Frequency Variation over	CLK_SEL=0,6 or gyro inactive	-10		+10	%	1			
Temperature	CLK_SEL=1,2,3,4,5 and gyro active	-1		+1	%	1			

Table 3. A.C. Electrical Characteristics

Notes:

- 1. Derived from validation or characterization of parts, not guaranteed in production.
- 2. Guaranteed by design.

3.2.3 Other Electrical Specifications

Typical Operating Circuit of section 4.2, VDD = 1.8V, VDDIO = 1.8V, T_A = 25°C, unless otherwise noted.

PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS	NOTES		
SERIAL INTERFACE								
SPI Operating Frequency, All Registers Read/Write	Low Speed Characterization		100 ±10%		kHz	1		
Registers Read/Write	High Speed Characterization		1	8	MHz	1, 2		
SPI Modes			Modes 0 and 3					
12C Operating Fraguency	All registers, Fast-mode			400	kHz	1		
I ² C Operating Frequency	All registers, Standard-mode			100	kHz	1		

Table 4. Other Electrical Specifications

Notes:

- 1. Derived from validation or characterization of parts, not guaranteed in production.
- 2. SPI clock duty cycle between 45% and 55% should be used for 8 MHz operation.



3.3 I²C TIMING CHARACTERIZATION

Typical Operating Circuit of section 4.2, VDD = 1.8V, VDDIO = 1.8V, T_A = 25°C, unless otherwise noted.

PARAMETERS	CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
I ² C TIMING	I ² C FAST-MODE					
f _{SCL} , SCL Clock Frequency				400	kHz	1
t _{HD.STA} , (Repeated) START Condition Hold Time		0.6			μs	1
t _{LOW} , SCL Low Period		1.3			μs	1
t _{HIGH} , SCL High Period		0.6			μs	1
t _{SU.STA} , Repeated START Condition Setup Time		0.6			μs	1
t _{HD.DAT} , SDA Data Hold Time		0			μs	1
t _{SU.DAT} , SDA Data Setup Time		100			ns	1
t _r , SDA and SCL Rise Time	C _b bus cap. from 10 to 400 pF	20+0.1C _b		300	ns	1
t _f , SDA and SCL Fall Time	C _b bus cap. from 10 to 400 pF	20+0.1C _b		300	ns	1
t _{SU.STO} , STOP Condition Setup Time		0.6			μs	1
t _{BUF} , Bus Free Time Between STOP and START Condition		1.3			μs	1
C _b , Capacitive Load for each Bus Line			< 400		pF	1
t _{VD.DAT} , Data Valid Time				0.9	μs	1
t _{VD.ACK} , Data Valid Acknowledge Time				0.9	μs	1

Table 5. I²C Timing Characteristics

Notes:

1. Based on characterization of 5 parts over temperature and voltage as mounted on evaluation board or in sockets.

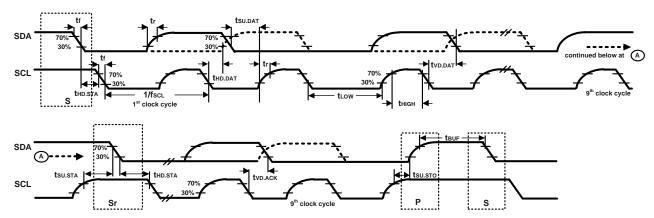


Figure 1. I²C Bus Timing Diagram



3.4 SPI TIMING CHARACTERIZATION

Typical Operating Circuit of section 4.2, VDD = 1.8V, VDDIO = 1.8V, T_A = 25°C, unless otherwise noted.

PARAMETERS	CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
SPI TIMING						
f _{SPC} , SPC Clock Frequency				8	MHz	1
t _{LOW} , SPC Low Period		56			ns	1
t _{нібн} , SPC High Period		56			ns	1
t _{SU.CS} , CS Setup Time		2			ns	1
t _{HD.CS} , CS Hold Time		63			ns	1
t _{SU.SDI} , SDI Setup Time		3			ns	1
t _{HD.SDI} , SDI Hold Time		7			ns	1
t _{VD.SDO} , SDO Valid Time	C _{load} = 20 pF			40	ns	1
t _{HD.SDO} , SDO Hold Time	C _{load} = 20 pF	6			ns	1
t _{DIS.SDO} , SDO Output Disable Time				20	ns	1
t _{Fall} , SCLK Fall Time				6.5	ns	2
t _{Rise} , SCLK Rise Time				6.5	ns	2

Table 6. SPI Timing Characteristics (8 MHz Operation)

Notes:

- 1. Based on characterization of 5 parts over temperature and voltage as mounted on evaluation board or in sockets.
- 2. Based on other parameter values.

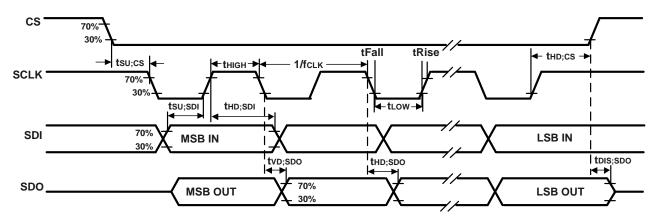


Figure 2. SPI Bus Timing Diagram



3.5 ABSOLUTE MAXIMUM RATINGS

Stress above those listed as "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these conditions is not implied. Exposure to the absolute maximum ratings conditions for extended periods may affect device reliability.

PARAMETER	RATING
Supply Voltage, VDD	-0.5V to 4V
Supply Voltage, VDDIO	-0.5V to 4V
REGOUT	-0.5V to 2V
Input Voltage Level (SAO, FSYNC, SCL, SDA)	-0.5V to VDDIO + 0.5V
Operating Temperature Range	-40°C to +85°C
Storage Temperature Range	-40°C to +125°C
Electrostatic Discharge (ESD) Protection	2 kV (HBM);
Electrostatic discharge (ESD) Protection	250V (MM)
Latch-up	JEDEC Class II (2),125°C
Latti-up	±100 mA

Table 7. Absolute Maximum Ratings



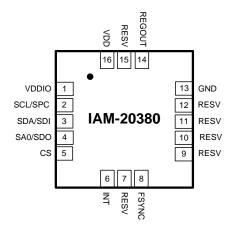
4 APPLICATIONS INFORMATION

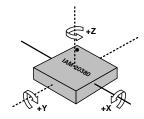
4.1 PIN OUT DIAGRAM AND SIGNAL DESCRIPTION

PIN NUMBER	PIN NAME	PIN DESCRIPTION			
1	VDDIO	Digital I/O supply voltage			
2	SCL/SPC	I ² C serial clock (SCL); SPI serial clock (SPC)			
3	SDA/SDI	I ² C serial data (SDA); SPI serial data input (SDI)			
4	SA0/SDO	I ² C slave address LSB (SAO); SPI serial data output (SDO)			
5	CS	Chip select (0 = SPI mode; 1 = I ² C mode)			
6	INT	Interrupt digital output (totem pole or open-drain)			
7	RESV	Reserved. Do not connect.			
8	FSYNC	Synchronization digital input (optional). Connect to GND if unused.			
9	RESV	Reserved. Connect to GND.			
10	RESV	Reserved. Connect to GND.			
11	RESV	Reserved. Connect to GND.			
12	RESV	Reserved. Connect to GND.			
13	GND	Connect to GND			
14	REGOUT	Regulator filter capacitor connection			
15	RESV	Reserved. Connect to GND.			
16	VDD	Power Supply			

Table 8. Signal Descriptions

Note: Power up with SCL/SPC and CS pins held low is not a supported use case. In case this power up approach is used, software reset is required using the PWR_MGMT_1 register, prior to initialization.





LGA Package (Top View) 16-pin, 3mm x 3mm x 0.75mm Typical Footprint and thickness

Orientation of Axes of Sensitivity and Polarity of Rotation

Figure 3. Pin out Diagram for IAM-20380 3.0x3.0x0.75mm LGA

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4.2 TYPICAL OPERATING CIRCUIT

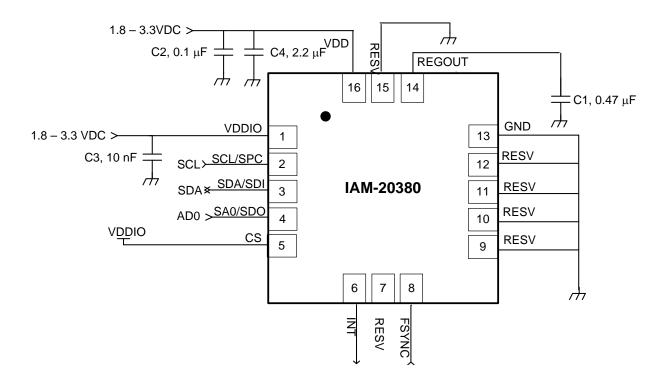


Figure 4. IAM-20380 LGA Application Schematic

Note: I^2C lines are open drain and pullup resistors (e.g. 10 k Ω) are required.

4.3 BILL OF MATERIALS FOR EXTERNAL COMPONENTS

COMPONENT	LABEL	SPECIFICATION	QUANTITY
REGOUT Capacitor	C1	X7R, 0.47 μF ±10%	1
VDD Dynass Canasitars	C2	X7R, 0.1 μF ±10%	1
VDD Bypass Capacitors	C4	X7R, 2.2 μF ±10%	1
VDDIO Bypass Capacitor	C3	X7R, 10 nF ±10%	1

Table 9. Bill of Materials

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4.4 BLOCK DIAGRAM

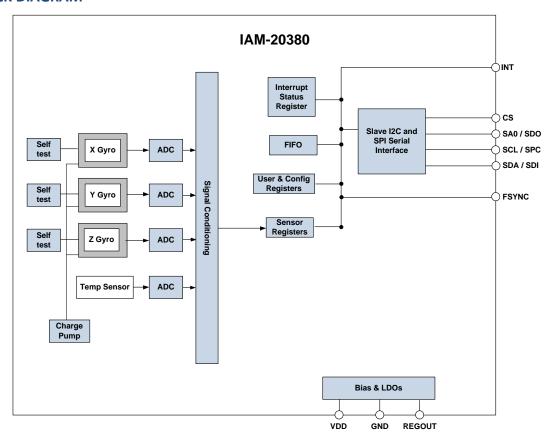


Figure 5. IAM-20380 Block Diagram

4.5 **OVERVIEW**

The IAM-20380 is comprised of the following key blocks and functions:

- Three-axis MEMS rate gyroscope sensor with 16-bit ADCs and signal conditioning
- Primary I²C and SPI serial communications interfaces
- Self-Test
- Clocking
- Sensor Data Registers
- FIFO
- Interrupts
- Digital-Output Temperature Sensor
- Bias and LDOs
- Charge Pump
- Standard Power Modes



4.6 THREE-AXIS MEMS GYROSCOPE WITH 16-BIT ADCS AND SIGNAL CONDITIONING

The IAM-20380 consists of three independent vibratory MEMS rate gyroscopes, which detect rotation about the X-, Y-, and Z- Axes. When the gyros are rotated about any of the sense axes, the Coriolis Effect causes a vibration that is detected by a capacitive pickoff. The resulting signal is amplified, demodulated, and filtered to produce a voltage that is proportional to the angular rate. This voltage is digitized using individual on-chip 16-bit Analog-to-Digital Converters (ADCs) to sample each axis. The full-scale range of the gyro sensors may be digitally programmed to ±250, ±500, ±1000, or ±2000 degrees per second (dps). The ADC sample rate is programmable from 8,000 samples per second, down to 3.9 samples per second, and user-selectable low-pass filters enable a wide range of cut-off frequencies.

4.7 I²C AND SPI SERIAL COMMUNICATIONS INTERFACES

The IAM-20380 communicates to a system processor using either a SPI or an I^2C serial interface. The IAM-20380 always acts as a slave when communicating to the system processor. The LSB of the I^2C slave address is set by pin 4 (SA0).

4.7.1 IAM-20380 Solution Using I²C Interface

In Figure 6, the system processor is an I²C master to the IAM-20380.

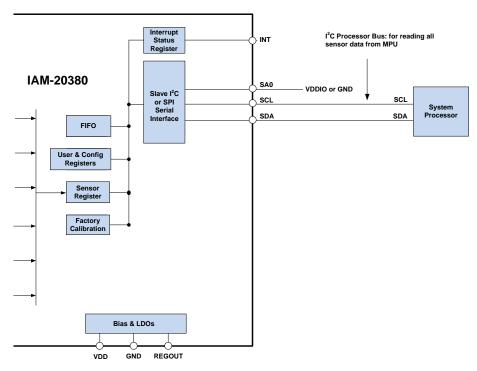


Figure 6. IAM-20380 Solution Using I²C Interface

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4.7.2 IAM-20380 Solution Using SPI Interface

In Figure 7, the system processor is an SPI master to the IAM-20380. Pins 2, 3, 4, and 5 are used to support the SPC, SDI, SDO, and CS signals for SPI communications.

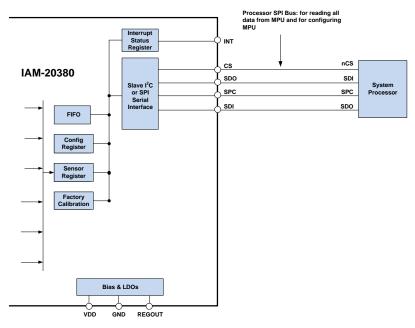


Figure 7. IAM-20380 Solution Using SPI Interface

4.8 SELF-TEST

Self-test allows for the testing of the mechanical and electrical portions of the sensors. The self-test for each measurement axis can be activated by means of the gyroscope self-test register (register 27).

When the self-test is activated, the electronics cause the sensors to be actuated and produce an output signal. The output signal is used to observe the self-test response.

The self-test response is defined as follows:

SELF-TEST RESPONSE = SENSOR OUTPUT WITH SELF-TEST ENABLED - SENSOR OUTPUT WITH SELF-TEST DISABLED

When the value of the self-test response is within the specified min/max limits of the product specification, the part has passed self-test. When the self-test response exceeds the min/max values, the part is deemed to have failed self-test.

4.9 CLOCKING

The IAM-20380 has a flexible clocking scheme, allowing a variety of internal clock sources to be used for the internal synchronous circuitry. This synchronous circuitry includes the signal conditioning and ADCs, and various control circuits and registers. An on-chip PLL provides flexibility in the allowable inputs for generating this clock.

Allowable internal sources for generating the internal clock are:

- a) An internal relaxation oscillator
- b) Auto-select between internal relaxation oscillator and gyroscope MEMS oscillator to use the best available source

The only setting supporting specified performance in all modes is option b). It is recommended that option b) be used.

4.10 SENSOR DATA REGISTERS

The sensor data registers contain the latest gyroscope and temperature measurement data. They are read-only registers, and are accessed via the serial interface. Data from these registers may be read anytime.

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4.11 FIFO

The IAM-20380 contains a 512-byte FIFO register that is accessible via the Serial Interface. The FIFO configuration register determines which data are written into the FIFO. Possible choices include gyro data, temperature readings, and FSYNC input. A FIFO counter keeps track of how many bytes of valid data are contained in the FIFO. The FIFO register supports burst reads. The interrupt function may be used to determine when new data are available.

4.12 INTERRUPTS

Interrupt functionality is configured via the Interrupt Configuration register. Items that are configurable include the INT pin configuration, the interrupt latching and clearing method, and triggers for the interrupt. Items that can trigger an interrupt are (1) Clock generator locked to new reference oscillator (used when switching clock sources); (2) new data are available to be read (from the FIFO and Data registers); (3) FIFO overflow. The interrupt status can be read from the Interrupt Status register.

4.13 DIGITAL-OUTPUT TEMPERATURE SENSOR

An on-chip temperature sensor and ADC are used to measure the IAM-20380 die temperature. The readings from the ADC can be read from the FIFO or the Sensor Data registers.

4.14 BIAS AND LDOS

The bias and LDO section generates the internal supply and the reference voltages and currents required by the IAM-20380. Its two inputs are an unregulated VDD and a VDDIO logic reference supply voltage. The LDO output is bypassed by a capacitor at REGOUT. For further details on the capacitor, please refer to the Bill of Materials for External Components.

4.15 CHARGE PUMP

An on-chip charge pump generates the high voltage required for the MEMS oscillator.

4.16 STANDARD POWER MODES

The following table lists the user-accessible power modes for IAM-20380.

MODE	NAME	GYRO
1	Sleep Mode	Off
2	Standby Mode	Drive On
3	Reserved	Off
4	Reserved	Off
5	Low-Power Mode	Duty-Cycled
6	Low-Noise Mode	On
7	Low-Noise Mode	On
8	Low-Power Mode	Duty-Cycled

Table 10. Standard Power Modes for IAM-20380

Notes:

Power consumption for individual modes can be found in section 3.2.1.

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5 PROGRAMMABLE INTERRUPTS

The IAM-20380 has a programmable interrupt system which can generate an interrupt signal on the INT pin. Status flags indicate the source of an interrupt. Interrupt sources may be enabled and disabled individually.

INTERRUPT NAME	MODULE
Motion Detection	Motion
FIFO Overflow	FIFO
Data Ready	Sensor Registers

Table 11. Table of Interrupt Sources



6 DIGITAL INTERFACE

6.1 I²C AND SPI SERIAL INTERFACES

The internal registers and memory of the IAM-20380 can be accessed using either I²C at 400 kHz or SPI at 8 MHz. SPI operates in four-wire mode.

PIN NUMBER	PIN NAME	PIN DESCRIPTION			
1	VDDIO	Digital I/O supply voltage.			
4	SA0 / SDO	I ² C Slave Address LSB (SA0); SPI serial data output (SDO)			
2	SCL / SPC	I ² C serial clock (SCL); SPI serial clock (SPC)			
3	SDA / SDI	I ² C serial data (SDA); SPI serial data input (SDI)			

Table 12. Serial Interface

Note: To prevent switching into I^2C mode when using SPI, the I^2C interface should be disabled by setting the I^2C _IF_DIS configuration bit. Setting this bit should be performed immediately after waiting for the time specified by the "Start-Up Time for Register Read/Write" in section 3.2.2.

For further information regarding the I2C IF DIS bit, please refer to sections 8 and 9 of this document.

6.2 I²C INTERFACE

 I^2C is a two-wire interface comprised of the signals serial data (SDA) and serial clock (SCL). In general, the lines are open-drain and bi-directional. In a generalized I^2C interface implementation, attached devices can be a master or a slave. The master device puts the slave address on the bus, and the slave device with the matching address acknowledges the master.

The IAM-20380 always operates as a slave device when communicating to the system processor, which thus acts as the master. SDA and SCL lines typically need pull-up resistors to VDD. The maximum bus speed is 400 kHz.

The slave address of the IAM-20380 is b110100X which is 7 bits long. The LSB bit of the 7-bit address is determined by the logic level on pin SAO. This allows two IAM-20380s to be connected to the same I²C bus. When used in this configuration, the address of one of the devices should be b1101000 (pin SAO is logic low) and the address of the other should be b1101001 (pin SAO is logic high).

6.3 IC COMMUNICATIONS PROTOCOL

START (S) and STOP (P) Conditions

Communication on the I²C bus starts when the master puts the START condition (S) on the bus, which is defined as a HIGH-to-LOW transition of the SDA line while SCL line is HIGH (see figure below). The bus is considered to be busy until the master puts a STOP condition (P) on the bus, which is defined as a LOW to HIGH transition on the SDA line while SCL is HIGH (see Figure 8).

Additionally, the bus remains busy if a repeated START (Sr) is generated instead of a STOP condition.

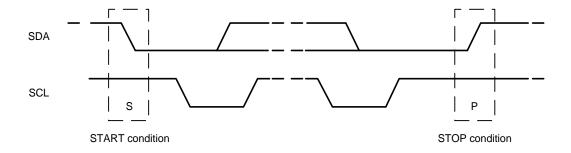


Figure 8. START and STOP Conditions

Data Format / Acknowledge

I²C data bytes are defined to be 8-bits long. There is no restriction to the number of bytes transmitted per data transfer. Each byte transferred must be followed by an acknowledge (ACK) signal. The clock for the acknowledge signal is generated by the master, while the receiver generates the actual acknowledge signal by pulling down SDA and holding it low during the HIGH portion of the acknowledge clock pulse.

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If a slave is busy and cannot transmit or receive another byte of data until some other task has been performed, it can hold SCL LOW, thus forcing the master into a wait state. Normal data transfer resumes when the slave is ready, and releases the clock line (refer to Figure 9).

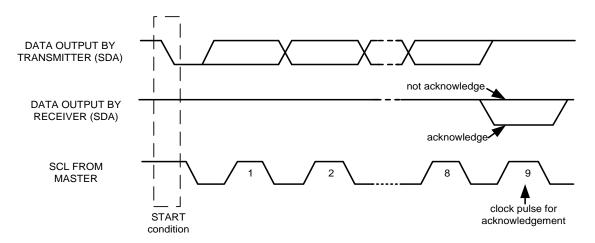


Figure 9. Acknowledge on the I2C Bus

Communications

After beginning communications with the START condition (S), the master sends a 7-bit slave address followed by an 8th bit, the read/write bit. The read/write bit indicates whether the master is receiving data from or is writing to the slave device. Then, the master releases the SDA line and waits for the acknowledge signal (ACK) from the slave device. Each byte transferred must be followed by an acknowledge bit. To acknowledge, the slave device pulls the SDA line LOW and keeps it LOW for the high period of the SCL line. Data transmission is always terminated by the master with a STOP condition (P), thus freeing the communications line. However, the master can generate a repeated START condition (Sr), and address another slave without first generating a STOP condition (P). A LOW to HIGH transition on the SDA line while SCL is HIGH defines the stop condition. All SDA changes should take place when SCL is low, with the exception of start and stop conditions.

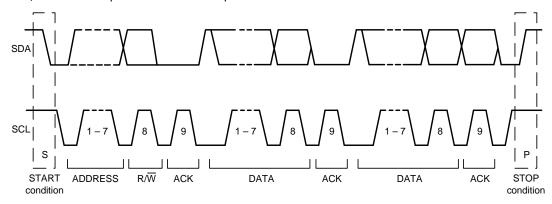


Figure 10. Complete I²C Data Transfer

To write the internal IAM-20380 registers, the master transmits the start condition (S), followed by the I²C address and the write bit (0). At the 9th clock cycle (when the clock is high), the IAM-20380 acknowledges the transfer. Then the master puts the register address (RA) on the bus. After the IAM-20380 acknowledges the reception of the register address, the master puts the register data onto the bus. This is followed by the ACK signal, and data transfer may be concluded by the stop condition (P). To write multiple bytes after the last ACK signal, the master can continue outputting data rather than transmitting a stop signal. In this case, the IAM-20380 automatically increments the register address and loads the data to the appropriate register. The following figures show single and two-byte write sequences.

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Single-Byte Write Sequence

Master	S	AD+W		RA		DATA		Р
Slave			ACK		ACK		ACK	

Burst Write Sequence

Master	S	AD+W		RA		DATA		DATA		Р
Slave			ACK		ACK		ACK		ACK	

To read the internal IAM-20380 registers, the master sends a start condition, followed by the I²C address and a write bit, and then the register address that is going to be read. Upon receiving the ACK signal from the IAM-20380, the master transmits a start signal followed by the slave address and read bit. As a result, the IAM-20380 sends an ACK signal and the data. The communication ends with a not acknowledge (NACK) signal and a stop bit from master. The NACK condition is defined such that the SDA line remains high at the 9th clock cycle. The following figures show single and two-byte read sequences.

Single-Byte Read Sequence

Master	S	AD+W		RA		S	AD+R			NACK	Р
Slave			ACK		ACK			ACK	DATA		

Burst Read Sequence

Master	S	AD+W		RA		S	AD+R			ACK		NACK	Р
Slave			ACK		ACK			ACK	DATA		DATA		

I²C TERMS

SIGNAL	DESCRIPTION
S	Start Condition: SDA goes from high to low while SCL is high
AD	Slave I ² C address
W	Write bit (0)
R	Read bit (1)
ACK	Acknowledge: SDA line is low while the SCL line is high at the 9 th clock cycle
NACK	Not-Acknowledge: SDA line stays high at the 9 th clock cycle
RA	IAM-20380 internal register address
DATA	Transmit or received data
Р	Stop condition: SDA going from low to high while SCL is high

Table 13. I²C Terms



6.5 **SPI INTERFACE**

SPI is a 4-wire synchronous serial interface that uses two control lines and two data lines. The IAM-20380 always operates as a Slave device during standard Master-Slave SPI operation.

With respect to the Master, the Serial Clock output (SPC), the Serial Data Output (SDO) and the Serial Data Input (SDI) are shared among the Slave devices. Each SPI slave device requires its own Chip Select (CS) line from the master.

CS goes low (active) at the start of transmission and goes back high (inactive) at the end. Only one CS line is active at a time, ensuring that only one slave is selected at any given time. The CS lines of the non-selected slave devices are held high, causing their SDO lines to remain in a high-impedance (high-z) state so that they do not interfere with any active devices.

SPI Operational Features

- 1. Data are delivered MSB first and LSB last
- 2. Data are latched on the rising edge of SPC
- Data should be transitioned on the falling edge of SPC
- The maximum frequency of SPC is 8 MHz
- 5. SPI read and write operations are completed in 16 or more clock cycles (two or more bytes). The first byte contains the SPI Address, and the following byte(s) contain(s) the SPI data. The first bit of the first byte contains the Read/Write bit and indicates the Read (1) or Write (0) operation. The following 7 bits contain the Register Address. In cases of multiplebyte Read/Writes, data are two or more bytes:

SPI Address format

MSB							LSB
R/W	A6	A5	A4	А3	A2	A1	Α0

SPI Data format

MSB							LSB
D7	D6	D5	D4	D3	D2	D1	D0

6. Supports Single or Burst Read/Writes.

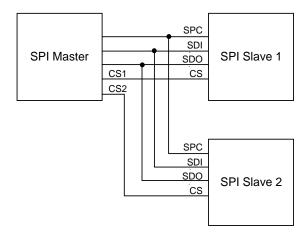


Figure 11. Typical SPI Master/Slave Configuration

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7 SERIAL INTERFACE CONSIDERATIONS

7.1 IAM-20380 SUPPORTED INTERFACES

The IAM-20380 supports I²C communications on its serial interface.

The IAM-20380's I/O logic levels are set to be VDDIO.

Figure 12 depicts a sample circuit of IAM-20380. It shows the relevant logic levels and voltage connections.

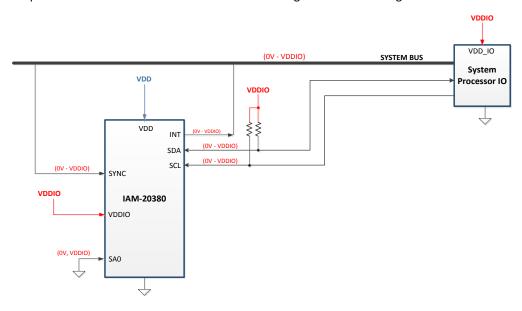


Figure 12. I/O Levels and Connections



8 REGISTER MAP

The following table lists the register map for the IAM-20380.

Addr (Hex)	Addr (Dec.)	Register Name	Serial I/F	Accessible (writable) in Sleep Mode	Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0
00	00	SELF_TEST_X_GYRO	R/W	N				XG_ST_	DATA[7:0]			
01	01	SELF_TEST_Y_GYRO	R/W	N				YG_ST_	DATA[7:0]			
02	02	SELF_TEST_Z_GYRO	R/W	N				ZG_ST_	DATA[7:0]			
13	19	XG_OFFS_USRH	R/W	N				X_OFFS_	USR [15:8]			
14	20	XG_OFFS_USRL	R/W	N		X_OFFS_USR [7:0]						
15	21	YG_OFFS_USRH	R/W	N				Y_OFFS_	USR [15:8]			
16	22	YG_OFFS_USRL	R/W	N				Y_OFFS	_USR [7:0]			
17	23	ZG_OFFS_USRH	R/W	N				Z_OFFS_	USR [15:8]			
18	24	ZG_OFFS_USRL	R/W	N				Z_OFFS	_USR [7:0]			
19	25	SMPLRT_DIV	R/W	N				SMPLR	Γ_DIV[7:0]			
1A	26	CONFIG	R/W	N	-	FIFO_ MODE	1	EXT_SYNC_SET[2:0]		DLPF_CFG[2:0]	
1B	27	GYRO_CONFIG	R/W	N	XG_ST	YG_ST	ZG_ST	FS_SE	L [1:0]	-	FCHOIC	CE_B[1:0]
1E	30	LP_MODE_CFG	R/W	N	GYRO_CYCL E	GYRO_CYCL G_AVGCFG[2:0]					-	
23	35	FIFO_EN	R/W	N	TEMP _FIFO_EN	XG_FIFO_EN	YG_FIFO_EN	ZG_FIFO_EN	-	-	-	-
36	54	FSYNC_INT	R/C	N	FSYNC_INT	-	-	-	-	-	-	-
37	55	INT_PIN_CFG	R/W	Υ	INT_LEVEL	INT_OPEN	LATCH _INT_EN	INT_RD _CLEAR	FSYNC_INT_L EVEL	FSYNC _INT_MODE_ EN	-	-
38	56	INT_ENABLE	R/W	Υ		FIFO _OFLOW _EN				GDRIVE_INT_ EN	-	DATA_RDY_I NT_EN
3A	58	INT_STATUS	R/C	N		-		FIFO _OFLOW _INT	-	GDRIVE_INT	-	DATA _RDY_INT
41	65	TEMP_OUT_H	R	N				TEMP_0	OUT[15:8]			
42	66	TEMP_OUT_L	R	N				TEMP_	OUT[7:0]			
43	67	GYRO_XOUT_H	R	N				GYRO_X	OUT[15:8]			
44	68	GYRO_XOUT_L	R	N				GYRO_X	KOUT[7:0]			
45	69	GYRO_YOUT_H	R	N				GYRO_Y	OUT[15:8]			
46	70	GYRO_YOUT_L	R	N				GYRO_	YOUT[7:0]			
47	71	GYRO_ZOUT_H	R	N				GYRO_Z	OUT[15:8]			
48	72	GYRO_ZOUT_L	R	N				GYRO_	ZOUT[7:0]			
68	104	SIGNAL_PATH_RESET	R/W	N	-	-	-	-	-	-	-	TEMP _RST
6A	106	USER_CTRL	R/W	N	-	FIFO_EN	-	I2C_IF _DIS	-	FIFO _RST	-	SIG_COND _RST
6B	107	PWR_MGMT_1	R/W	Υ	DEVICE_RES ET	SLEEP	-	GYRO_ STANDBY	TEMP_DIS		CLKSEL[2:0]	
6C	108	PWR_MGMT_2	R/W	Υ	FIFO_LP_EN STBY_XG STBY_YG STBY_ZG							
72	114	FIFO_COUNTH	R	N	- FIFO_COUNT[12:8]							
73	115	FIFO_COUNTL	R	N	FIFO_COUNT[7:0]							
74	116	FIFO_R_W	R/W	N		FIFO_DATA[7:0]						
75	117	WHO_AM_I	R	N				WHO	AMI[7:0]			

Note: Register Names ending in _H and _L contain the high and low bytes, respectively, of an internal register value.

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In the detailed register tables that follow, register names are in capital letters, while register values are in capital letters and italicized. For example, the GYRO_XOUT_H register (Register 67) contains the 8 most significant bits, *GYRO_XOUT*[15:8], of the 16-bit X-Axis gyroscope measurement, *GYRO_XOUT*.

The reset value is 0x00 for all registers other than the registers below, also the self-test registers contain pre-programmed values and will not be 0x00 after reset.

- Register 107 (0x40) Power Management 1
- Register 117 (0xB5) WHO_AM_I

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9 REGISTER DESCRIPTIONS

This section describes the function and contents of each register within the IAM-20380.

Note: The device will come up in sleep mode upon power-up.

9.1 REGISTERS 0 TO 2 – GYROSCOPE SELF-TEST REGISTERS

Register Name: SELF_TEST_X_GYRO, SELF_TEST_Y_GYRO, SELF_TEST_Z_GYRO

Type: READ/WRITE

Register Address: 00, 01, 02 (Decimal); 00, 01, 02 (Hex)

REGISTER	BIT	NAME	FUNCTION
			The value in this register indicates the self-test output generated during
SELF_TEST_X_GYRO	[7:0]	XG_ST_DATA[7:0]	manufacturing tests. This value is to be used to check against
			subsequent self-test outputs performed by the end user.
			The value in this register indicates the self-test output generated during
SELF_TEST_Y_GYRO	[7:0]	YG_ST_DATA[7:0]	manufacturing tests. This value is to be used to check against
			subsequent self-test outputs performed by the end user.
			The value in this register indicates the self-test output generated during
SELF_TEST_Z_GYRO	[7:0]	ZG_ST_DATA[7:0]	manufacturing tests. This value is to be used to check against
			subsequent self-test outputs performed by the end user.

The equation to convert self-test codes in OTP to factory self-test measurement is:

$$ST \quad OTP = (2620/2^{FS}) * 1.01^{(ST_code-1)}$$
 (1sb)

where ST_OTP is the value that is stored in OTP of the device, FS is the Full Scale value, and ST_code is based on the Self-Test value (ST_FAC) determined in InvenSense's factory final test and calculated based on the following equation:

$$ST_code = round(\frac{\log(ST_FAC/(2620/2^{FS}))}{\log(1.01)}) + 1$$

9.2 REGISTER 19 – GYRO OFFSET ADJUSTMENT REGISTER

Register Name: XG_OFFS_USRH Register Type: READ/WRITE

Register Address: 19 (Decimal); 13 (Hex)

BIT	NAME	FUNCTION
[7.0]	V OFFC HODIAE O	Bits 15 to 8 of the 16-bit offset of X gyroscope (2's complement). This register is
[7:0]	X_OFFS_USR[15:8]	used to remove DC bias from the sensor output. The value in this register is added to the gyroscope sensor value before going into the sensor register.

9.3 REGISTER 20 – GYRO OFFSET ADJUSTMENT REGISTER

Register Name: XG_OFFS_USRL Register Type: READ/WRITE

Register Address: 20 (Decimal); 14 (Hex)

BIT	NAME	FUNCTION
[7:0]	X_OFFS_USR[7:0]	Bits 7 to 0 of the 16-bit offset of X gyroscope (2's complement). This register is used to remove DC bias from the sensor output. The value in this register is added to the gyroscope sensor value before going into the sensor register.

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9.4 REGISTER 21 – GYRO OFFSET ADJUSTMENT REGISTER

Register Name: YG_OFFS_USRH Register Type: READ/WRITE

Register Address: 21 (Decimal); 15 (Hex)

BIT	NAME	FUNCTION
[7:0]	Y_OFFS_USR[15:8]	Bits 15 to 8 of the 16-bit offset of Y gyroscope (2's complement). This register is used to remove DC bias from the sensor output. The value in this register is added to the gyroscope sensor value before going into the sensor register.

9.5 REGISTER 22 – GYRO OFFSET ADJUSTMENT REGISTER

Register Name: YG_OFFS_USRL Register Type: READ/WRITE

Register Address: 22 (Decimal); 16 (Hex)

BIT	NAME	FUNCTION
[7:0]	Y OFFS USR[7:0]	Bits 7 to 0 of the 16-bit offset of Y gyroscope (2's complement). This register is used to remove DC bias from the sensor output. The value in this register is
[7.0]	` '	added to the gyroscope sensor value before going into the sensor register.

9.6 REGISTER 23 – GYRO OFFSET ADJUSTMENT REGISTER

Register Name: ZG_OFFS_USRH Register Type: READ/WRITE

Register Address: 23 (Decimal); 17 (Hex)

BIT	NAME	FUNCTION
[7:0]	Z OFFS USR[15:8]	Bits 15 to 8 of the 16-bit offset of Z gyroscope (2's complement). This register is used to remove DC bias from the sensor output. The value in this register is
[7:0]	Z_OFFS_OSK[15:8]	added to the gyroscope sensor value before going into the sensor register.

9.7 REGISTER 24 – GYRO OFFSET ADJUSTMENT REGISTER

Register Name: ZG_OFFS_USRL Register Type: READ/WRITE

Register Address: 24 (Decimal); 18 (Hex)

BIT	NAME	FUNCTION
[7:0]	Z_OFFS_USR[7:0]	Bits 7 to 0 of the 16-bit offset of Z gyroscope (2's complement). This register is used to remove DC bias from the sensor output. The value in this register is added to the gyroscope sensor value before going into the sensor register.

9.8 REGISTER 25 – SAMPLE RATE DIVIDER

Register Name: SMPLRT_DIV Register Type: READ/WRITE

Register Address: 25 (Decimal); 19 (Hex)

BIT	NAME	FUNCTION
[7:0]	SMPLRT_DIV[7:0]	Divides the internal sample rate (see register CONFIG) to generate the sample rate that
		controls sensor data output rate, FIFO sample rate.
		Note : This register is only effective when FCHOICE_B register bits are 2'b00, and (0 < DLPF_CFG < 7).
		This is the update rate of the sensor register:
		SAMPLE_RATE = INTERNAL_SAMPLE_RATE / (1 + SMPLRT_DIV)
		Where INTERNAL_SAMPLE_RATE = 1 kHz

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9.9 REGISTER 26 – CONFIGURATION

Register Name: CONFIG
Register Type: READ/WRITE

Register Address: 26 (Decimal); 1A (Hex)

BIT	NAME		FU	NCTION				
[7]	-	Always set to 0	Always set to 0					
[6]	FIFO_MODE	When set to '1', wh	When set to '1', when the FIFO is full, additional writes will not be written to FIFO.					
		When set to '0', wh	en the FIFO is full, addition	onal writes will be written to th	ne FIFO, replacing			
		the oldest data.						
[5:3]	EXT_SYNC_SET[2:0]	Enables the FSYNC	pin data to be sampled.		_			
			EXT_SYNC_SET	FSYNC bit location				
			2 GYRO_XOUT_L[0]					
			3 GYRO_YOUT_L[0]					
			4	GYRO_ZOUT_L[0]				
			5	RESERVED				
			6	RESERVED				
			7	RESERVED				
		FSYNC will be latched	ed to capture short strobe	es. This will be done such that	if FSYNC toggles,			
		the latched value to	oggles, but won't toggle a	gain until the new latched valu	ue is captured by			
		the sample rate stro	the sample rate strobe.					
[2:0]	DLPF CFG[2:0]	For the DLPF to be	used, FCHOICE B[1:0] is 2	′b00.				
_		See Table 14.						

The DLPF is configured by *DLPF_CFG*, when *FCHOICE_B* [1:0] = 2b'00. The gyroscope and temperature sensor are filtered according to the value of *DLPF_CFG* and *FCHOICE_B* as shown in Table 14.

FCHOICE_B		DI DE CEC		Temperature Sensor		
<1>	<0>	DLPF_CFG	3-dB BW (Hz)	Noise BW (Hz)	Rate (kHz)	3-dB BW (Hz)
Х	1	Х	8173	8595.1	32	4000
1	0	X	3281	3451.0	32	4000
0	0	0	250	306.6	8	4000
0	0	1	176	177.0	1	188
0	0	2	92	108.6	1	98
0	0	3	41	59.0	1	42
0	0	4	20	30.5	1	20
0	0	5	10	15.6	1	10
0	0	6	5	8.0	1	5
0	0	7	3281	3451.0	8	4000

Table 14. Configuration



9.10 REGISTER 27 – GYROSCOPE CONFIGURATION

Register Name: GYRO_CONFIG Register Type: READ/WRITE

Register Address: 27 (Decimal); 1B (Hex)

BIT	NAME	FUNCTION		
[7]	XG_ST	X Gyro self-test		
[6]	YG_ST	Y Gyro self-test		
[5]	ZG_ST	Z Gyro self-test		
		Gyro Full Scale Select:		
		00 = ±250 dps		
[4:3]	FS_SEL[1:0]	01= ±500 dps		
		10 = ±1000 dps		
		11 = ±2000 dps		
[2]	-	Reserved.		
[1:0]	FCHOICE_B[1:0]	Used to bypass DLPF as shown in Table 14 above.		

9.11 REGISTER 30 - LOW POWER MODE CONFIGURATION

Register Name: LP_MODE_CFG Register Type: READ/WRITE

Register Address: 30 (Decimal); 1E (Hex)

BIT	NAME	FUNCTION
[7]	GYRO_CYCLE	When set to '1' low-power gyroscope mode is enabled. Default setting is '0'
[6:4]	G_AVGCFG[2:0]	Averaging filter configuration for low-power gyroscope mode. Default setting is '000'
[3:0]	-	Reserved.

To operate in low-power mode, GYRO_CYCLE should be set to '1.' Gyroscope filter configuration is determined by G_AVGCFG[2:0] that sets the averaging filter configuration. It is not dependent on DLPF_CFG[2:0].

Table 15 shows some example configurations for low power mode.

FCHOICE	_B	0	0	0	0	0	0	0	0
G_AVGCFG		0	1	2	3	4	5	6	7
Average	!S	1x	2x	4x	8x	16x	32x	64x	128x
Ton (ms	(;	1.73	2.23	3.23	5.23	9.23	17.23	33.23	65.23
Noise BW	(Hz)	650.8	407.1	224.2	117.4	60.2	30.6	15.6	8.0
Noise (dps) TYP based on 0.008º/s/√Hz		0.20	0.16	0.12	0.09	0.06	0.04	0.03	0.02
SMPLRT_DIV	ODR (Hz)			Cur	rent Consum	ption (mA) T	/P		
255	3.9	1.3	1.3	1.3	1.3	1.4	1.4	1.5	1.8
99	10.0	1.3	1.3	1.4	1.4	1.5	1.6	1.9	2.5
64	15.4	1.4	1.4	1.4	1.5	1.6	1.8	2.2	N/A
32	30.3	1.4	1.4	1.5	1.6	1.8	2.2	NI.	′^
19	50.0	1.5	1.5	1.6	1.8	2.1	2.8	N/	A
9	100.0	1.6	1.7	1.9	2.2	3.0		N/A	
7	125.0	1.7	1.8	2.0	2.5		N/	'A	
4	200.0	1.9	2.1	2.5			N/A		
3	250.0	2.1	2.3	2.7			IN/A		
2	333.3	2.3	2.6		N/A				
1	500.0	2.9				N/A			

Table 15. Example Configurations for Low Power Mode



9.12 REGISTER 35 – FIFO ENABLE

Register Name: FIFO_EN
Register Type: READ/WRITE

Register Address: 35 (Decimal); 23 (Hex)

BIT	NAME	FUNCTION
		1 – Write TEMP_OUT_H and TEMP_OUT_L to the FIFO at the sample rate; If enabled,
[7]	TEMP_FIFO_EN	buffering of data occurs even if data path is in standby.
		0 – Function is disabled.
		1 – Write GYRO_XOUT_H and GYRO_XOUT_L to the FIFO at the sample rate; If enabled,
[6]	XG_FIFO_EN	buffering of data occurs even if data path is in standby.
		0 – Function is disabled.
		1 – Write GYRO_YOUT_H and GYRO_YOUT_L to the FIFO at the sample rate; If enabled,
		buffering of data occurs even if data path is in standby.
[5]	YG_FIFO_EN	0 – Function is disabled.
		Note : Enabling any one of the bits corresponding to the Gyros or Temp data paths, data are buffered into
		the FIFO even though that data path is not enabled.
		1 – Write GYRO_ZOUT_H and GYRO_ZOUT_L to the FIFO at the sample rate; If enabled,
[4]	ZG_FIFO_EN	buffering of data occurs even if data path is in standby.
		0 – Function is disabled.
[3:0]	-	Reserved.

9.13 REGISTER 54 – FSYNC INTERRUPT STATUS

Register Name: FSYNC_INT
Register Type: READ to CLEAR

Register Address: 54 (Decimal); 36 (Hex)

BIT	NAME	FUNCTION
[7]	FSYNC INT	This bit automatically sets to 1 when a FSYNC interrupt has been generated. The bit
[7]	FSYNC_INT	

9.14 REGISTER 55 - INT/DRDY PIN / BYPASS ENABLE CONFIGURATION

Register Name: INT_PIN_CFG
Register Type: READ/WRITE

Register Address: 55 (Decimal); 37 (Hex)

BIT	NAME	FUNCTION			
[7]	INT LEVEL	1 – The logic level for INT/DRDY pin is active low.			
[7]	INT_LEVEL	0 – The logic level for INT/DRDY pin is active high.			
[6]	INT OPEN	1 – INT/DRDY pin is configured as open drain.			
[O]	INI_OPEN	0 – INT/DRDY pin is configured as push-pull.			
(E)	LATCH INT EN	1 – INT/DRDY pin level held until interrupt status is cleared.			
[5]	LATCH_INT_EN	0 – INT/DRDY pin indicates interrupt pulse's width is 50 μs.			
[4]	INT_RD_CLEAR	1 – Interrupt status is cleared if any read operation is performed.			
[4]		0 – Interrupt status is cleared only by reading INT_STATUS register			
[2]	FSYNC_INT_LEVEL	1 – The logic level for the FSYNC pin as an interrupt is active low.			
[3]		0 – The logic level for the FSYNC pin as an interrupt is active high.			
		When this bit is equal to 1, the FSYNC pin will trigger an interrupt when it transitions to			
[2]	FSYNC_INT_MODE_EN	the level specified by FSYNC_INT_LEVEL. When this bit is equal to 0, the FSYNC pin is			
		disabled from causing an interrupt.			
[1]	-	Reserved.			
[0]	-	Always set to 0.			



9.15 REGISTER 56 – INTERRUPT ENABLE

Register Name: INT_ENABLE Register Type: READ/WRITE

Register Address: 56 (Decimal); 38 (Hex)

BIT	NAME	FUNCTION
[7:5]	-	Reserved.
[4]	FIFO_OFLOW_EN 1 — Enables a FIFO buffer overflow to generate an interrupt. 0 — Function is disabled.	
[3]	-	Reserved.
[2]	GDRIVE_INT_EN	Gyroscope Drive System Ready interrupt enable.
[1]	-	Reserved.
[0]	DATA_RDY_INT_EN	Data ready interrupt enable.

9.16 REGISTER 58 - INTERRUPT STATUS

Register Name: INT_STATUS
Register Type: READ to CLEAR

Register Address: 58 (Decimal); 3A (Hex)

BIT	NAME	FUNCTION	
[7:5]	-	Reserved.	
[4]	FIFO_OFLOW_INT	This bit automatically sets to 1 when a FIFO buffer overflow has been generated. The bit clears to 0 after the register has been read.	
[3]	-	Reserved.	
[2]	GDRIVE_INT	Gyroscope Drive System Ready interrupt	
[1]	-	Reserved.	
[0]	DATA_RDY_INT	This bit automatically sets to 1 when a Data Ready interrupt is generated. The bit clears to 0 after the register has been read.	

9.17 REGISTERS 65 AND 66 - TEMPERATURE MEASUREMENT

Register Name: TEMP_OUT_H Register Type: READ only

Register Address: 65 (Decimal); 41 (Hex)

BIT	NAME	FUNCTION
[7:0]	TEMP_OUT[15:8]	High byte of the temperature sensor output

Register Name: TEMP_OUT_L Register Type: READ only

Register Address: 66 (Decimal); 42 (Hex)

BIT	NAME	FUNCTION		
	TEMP_OUT[7:0]	Low byte of the temperature sensor output	w byte of the temperature sensor output	
[7:0]		TEMP_degC = ((TEMP_OUT -	TEMP_degC = ((TEMP_OUT -	
[7:0]		RoomTemp_Offset)/Temp_Sensitivity) + 25degC	RoomTemp_Offset)/Temp_Sensitivity) + 25degC	

9.18 REGISTERS 67 TO 72 – GYROSCOPE MEASUREMENTS

Register Name: GYRO_XOUT_H
Register Type: READ only

Register Address: 67 (Decimal); 43 (Hex)

BIT	NAME	FUNCTION	
[7:0]	GYRO_XOUT[15:8]	High byte of the X-Axis gyroscope output.	

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Register Name: GYRO_XOUT_L Register Type: READ only

Register Address: 68 (Decimal); 44 (Hex)

BIT	NAME	FUNCTION		
	GYRO_XOUT[7:0]	Low byte of the X-Axis gyroscope output		
[7:0]		GYRO_XOUT =	Gyro_Sensitivity * X_angular_rate	
[7.0]		Nominal	FS_SEL = 0	
		Conditions	Gyro_Sensitivity = 131 LSB/(dps)	

Register Name: GYRO_YOUT_H Register Type: READ only

Register Address: 69 (Decimal); 45 (Hex)

BIT	NAME	FUNCTION
[7:0]	GYRO_YOUT[15:8]	High byte of the Y-Axis gyroscope output.

Register Name: GYRO_YOUT_L Register Type: READ only

Register Address: 70 (Decimal); 46 (Hex)

BIT	NAME		FUNCTION
	GYRO_YOUT[7:0]	Low byte of the	Y-Axis gyroscope output
[7:0]		GYRO_YOUT =	Gyro_Sensitivity * Y_angular_rate
[7.0]		Nominal	FS_SEL = 0
		Conditions	Gyro_Sensitivity = 131 LSB/(dps)

Register Name: GYRO_ZOUT_H Register Type: READ only

Register Address: 71 (Decimal); 47 (Hex)

BIT	NAME	FUNCTION
[7:0]	GYRO ZOUT[15:8]	High byte of the Z-Axis gyroscope output.

Register Name: GYRO_ZOUT_L Register Type: READ only

Register Address: 72 (Decimal); 48 (Hex)

BIT	NAME		FUNCTION
[7:0]	GYRO_YOUT[7:0]	Low byte of the Z-	Axis gyroscope output
		GYRO_ZOUT =	Gyro_Sensitivity * Z_angular_rate
		Nominal	FS_SEL = 0
		Conditions	Gyro_Sensitivity = 131 LSB/(dps)

9.19 REGISTER 104 - SIGNAL PATH RESET

Register Name: SIGNAL_PATH_RESET

Register Type: READ/WRITE

Register Address: 104 (Decimal); 68 (Hex)

_	•	
BIT	NAME	FUNCTION
[7:1]	-	Reserved.
[0]	TEMP_RST	Reset temp digital signal path. Note: Sensor registers are not cleared. Use SIG COND RST to clear sensor registers.

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9.20 REGISTER 106 - USER CONTROL

Register Name: USER_CTRL Register Type: READ/WRITE

Register Address: 106 (Decimal); 6A (Hex)

BIT	NAME	FUNCTION	
[7]	-	Reserved.	
[6]	FIFO_EN	1 – Enable FIFO operation mode. 0 – Disable FIFO access from serial interface. To disable FIFO writes by DMA, use FIFO_EN register.	
[5]	=	Reserved.	
[4]	I2C_IF_DIS	1 – Disable I ² C Slave module and put the serial interface in SPI mode only.	
[3]	-	Reserved.	
[2]	FIFO_RST	1 – Reset FIFO module. Reset is asynchronous. This bit auto clears after one clock cycle of the internal 20 MHz clock.	
[1]	-	Reserved	
[0]	SIG_COND_RST	1 – Reset all gyro digital signal path and temperature digital signal path. This bit also clears all the sensor registers.	

9.21 REGISTER 107 – POWER MANAGEMENT 1

Register Name: PWR_MGMT_1
Register Type: READ/WRITE

Register Address: 107 (Decimal); 6B (Hex)

BIT	NAME	FUNCTION	
[7]	DEVICE_RESET	1 – Reset the internal registers and restores the default settings. The bit automatically clears to 0 once the reset is done.	
[6]	SLEEP	When set to 1, the chip is set to sleep mode. Note: The default value is 1, the chip comes up in Sleep mode.	
[5]	RESERVED		
[4]	GYRO_STANDBY	When set, the gyro drive and pll circuitry are enabled, but the sense paths are disabled. This is a low power mode that allows quick enabling of the gyros.	
[3]	TEMP_DIS	When set to 1, this bit disables the temperature sensor.	
[2:0]	CLKSEL[2:0]	Code Clock Source Internal 20 MHz oscillator. Auto selects the best available clock source – PLL if ready, else use the Internal oscillator Auto selects the best available clock source – PLL if ready, else use the Internal oscillator Auto selects the best available clock source – PLL if ready, else use the Internal oscillator Auto selects the best available clock source – PLL if ready, else use the Internal oscillator Auto selects the best available clock source – PLL if ready, else use the Internal oscillator Internal 20.MHz oscillator. Stops the clock and keeps timing generator in reset.	

Note: The default value of CLKSEL[2:0] is 000. It is required that CLKSEL[2:0] be set to 001 to achieve full gyroscope performance.



9.22 REGISTER 108 – POWER MANAGEMENT 2

Register Name: PWR_MGMT_2
Register Type: READ/WRITE

Register Address: 108 (Decimal); 6C (Hex)

BIT	NAME	FUNCTION
[7:3]	-	Reserved.
[2]	STBY_XG	1 – X gyro is disabled. 0 – X gyro is on.
[1]	STBY_YG	1 – Y gyro is disabled. 0 – Y gyro is on.
[0]	STBY_ZG	1 – Z gyro is disabled. 0 – Z gyro is on.

9.23 REGISTERS 114 AND 115 – FIFO COUNT REGISTERS

Register Name: FIFO_COUNTH Register Type: READ Only

Register Address: 114 (Decimal); 72 (Hex)

BIT	NAME	FUNCTION
[7:5]	-	Reserved.
[4:0]	FIFO_COUNT[12:8]	High Bits; count indicates the number of written bytes in the FIFO. Reading this byte latches the data for both FIFO COUNTH, and FIFO COUNTL.

Register Name: FIFO_COUNTL Register Type: READ Only

Register Address: 115 (Decimal); 73 (Hex)

BIT	NAME	FUNCTION
		Low Bits; count indicates the number of written bytes in the FIFO.
[7:0]	FIFO_COUNT[7:0]	NOTE: Must read FIFO_COUNTH to latch new data for both
		FIFO_COUNTH and FIFO_COUNTL.

9.24 REGISTER 116 - FIFO READ WRITE

Register Name: FIFO_R_W Register Type: READ/WRITE

Register Address: 116 (Decimal); 74 (Hex)

BIT	NAME	FUNCTION
[7:0]	FIFO DATA[7:0]	Read/Write command provides Read or Write operation for the FIFO.

Description:

This register is used to read and write data from the FIFO buffer.

Data are written to the FIFO in order of register number (from lowest to highest). If all the FIFO enable flags (see below) are enabled, the contents of registers 59 through 72 will be written in order at the Sample Rate.

The contents of the sensor data registers (Registers 59 to 72) are written into the FIFO buffer when their corresponding FIFO enable flags are set to 1 in FIFO_EN (Register 35).

If the FIFO buffer has overflowed, the status bit FIFO_OFLOW_INT is automatically set to 1. This bit is located in INT_STATUS (Register 58). When the FIFO buffer has overflowed, the oldest data will be lost and new data will be written to the FIFO unless register 26 CONFIG, bit[6] FIFO_MODE = 1.

If the FIFO buffer is empty, reading register FIFO_DATA will return a unique value of 0xFF until new data are available. Normal data are precluded from ever indicating 0xFF, so 0xFF gives a trustworthy indication of FIFO empty.

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9.25 **REGISTER 117 – WHO AM I**

Register Name: WHO_AM_I Register Type: READ only

Register Address: 117 (Decimal); 75 (Hex)

BIT	NAME	FUNCTION
[7:0]	WHOAMI	Register to indicate to user which device is being accessed.

This register is used to verify the identity of the device. The contents of WHOAMI is an 8-bit device ID. The default value of the register is 0xB5. This is different from the I^2C address of the device as seen on the slave I^2C controller by the applications processor. The I^2C address of the IAM-20380 is 0x68 or 0x69 depending upon the value driven on AD0 pin.

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10 ASSEMBLY

This section provides general guidelines for assembling InvenSense Micro Electro-Mechanical Systems (MEMS) gyros packaged in LGA package.

10.1 ORIENTATION OF AXES

Figure 13 shows the orientation of the axes of sensitivity and the polarity of rotation. Note the pin 1 identifier (•) in the figure.

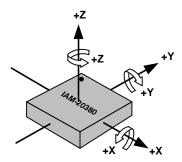


Figure 13. Orientation of Axes of Sensitivity and Polarity of Rotation



10.2 PACKAGE DIMENSIONS

16 Lead LGA (3x3x0.75) mm NiAu pad finish

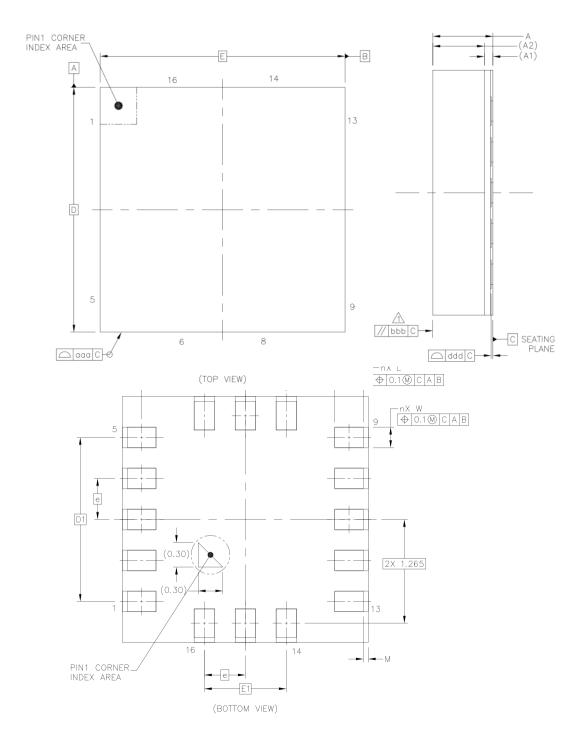


Figure 14. Package Dimensions



		DIME	DIMENSIONS IN MILLIMETERS		
	SYMBOLS	MIN	NOM	MAX	
Total Thickness	Α	0.7	0.75	0.8	
Substrate Thickness	A1	C	0.105 REF		
Mold Thickness	A2	(0.63 REF		
Body Size	D	2.9	3	3.1	
	E	2.9	3	3.1	
Lead Width	W	0.2	0.25	0.3	
Lead Length	L	0.3	0.35	0.4	
Lead Pitch	e	C	0.5 BSC		
Lead Count	n		16		
Edge Ball Center to Center	D1		2 BSC		
	E1		1 BSC		
Body Center to Contact Ball	SD		BSC		
	SE		BSC		
Ball Width	b				
Ball Diameter					
Ball Opening					
Ball Pitch	e1				
Ball Count	n1				
Pre-Solder					
Package Edge Tolerance	aaa	0.1			
Mold Flatness	bbb		0.2		
Coplanarity	ddd		0.08		
Ball Offset (Package)	eee				
Ball Offset (Ball)	fff				
Lead Edge to Package Edge	M	0.01	0.06	0.11	

Figure 15. Package Dimensions

Downloaded from Arrow.com.



11 PART NUMBER PACKAGE MARKING

The part number package marking for IAM-20380 devices is summarized below:

PART NUMBER	PART NUMBER PACKAGE MARKING
IAM-20380	IA238

Table 16. Part Number Package Marking

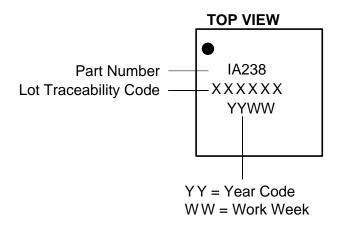


Figure 16. Part Number Package Marking



12 REFERENCE

Please refer to "InvenSense MEMS Handling Application Note (AN-IVS-0002A-00)" for the following information:

- Manufacturing Recommendations
 - o Assembly Guidelines and Recommendations
 - PCB Design Guidelines and Recommendations
 - o MEMS Handling Instructions
 - o ESD Considerations
 - o Reflow Specification
 - o Storage Specifications
 - Package Marking Specification
 - o Tape & Reel Specification
 - o Reel & Pizza Box Label
 - o Packaging
 - o Representative Shipping Carton Label
- Compliance
 - o Environmental Compliance
 - o DRC Compliance
 - o Compliance Declaration Disclaimer



13 REVISION HISTORY

REVISION DATE	REVISION	DESCRIPTION
12/21/2016	1.0	Initial Release

Document Number: DS-000195



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